

MAR 02 2004

Docket No. 740819-559

1765

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of)

Shin HASHIMOTO et al.)

Serial No. 09/856,823)

Filed: May 25, 2001)

For: METHOD FOR FABRICATING SEMICONDUCTOR)

DEVICE)

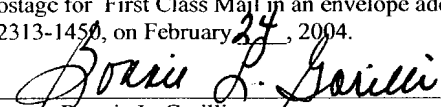
Examiner: Matthew J. Song

Group Art Unit: 1765

Confirmation No. 3480

Certificate of Mailing

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage for First Class Mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450, on February 24, 2004.


Name: Bonnie L. Garilli

REQUEST FOR ACKNOWLEDGMENT OF
INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
Alexandria, VA 22313-1450

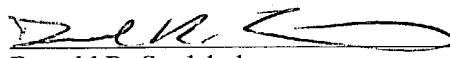
Sir:

An Information Disclosure Statement with Form PTO-1449 was filed in the above-identified patent application on August 8, 2003. Applicants have not yet received back from the Examiner a copy of the Form PTO-1449 initialed to acknowledge the fact that the Examiner has considered the cited disclosed information.

The Examiner is requested to initial and return to the undersigned a copy of the subject Form PTO-1449.

Should there be any questions concerning this communication, please telephone the undersigned at the number set forth below.

Respectfully submitted,


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Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete if Known	
Application Number		09/856,823			
Filing Date		May 25, 2001			
First Named Inventor		Shin HASHIMOTO et al.			
Art Unit		1765			
Examiner Name		Matthew J. SONG			
Attorney Docket Number		740819-559			
Sheet	1	of	1		

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	U.S. Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		Number - Kind Code ² (if known)				
		US-4,861,750	08-29-1989	Nogawa et al.		
		US-4,992,298	02-12-1991	Deutchman et al.		
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FOREIGN PATENT DOCUMENTS						
Examiner Initials [*]	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³	Number ⁴ Kind Code ² (if known)			

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials [*]	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
		M. MOLL et al., "Relation Between Microscopic Defects And Macroscopic Changes In Silicon Detector Properties After Hadron Irradiation".	
		B. GERSEY et al., "Neutron Dosimetry Using Tissue Equivalent And Silicon Equivalent Proportional Counters For Eight High-Energy Neutron Spectra".	
		E. NORMAND et al., "Neutron-Induced Single Event Burnout in High Voltage Electronics", IEEE, Dec. 1997.	
		D. McGregor et al., "Bulk GaAs-Based Neutron Detectors For Spent Fuel Analysis", ICON-8827, April 2-6, 2000.	

Examiner Signature		Date Considered	
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

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